

Application Manual

OV-7604-C7 Medical

Low Power Clock Oscillator 32.768 kHz

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OV-7604-C7 Medical

Low Power Clock Oscillator 32.768 kHz

1. OVERVIEW

- Oscillator with built-in “Tuning Fork” crystal oscillating at 32.768 kHz
- Very tight frequency tolerance: ± 20 ppm
- Excellent oscillator stability: < 1.5 ppm/V
- High shock and vibration resistance
- Wide operating voltage range: 1.2 V to 5.5 V
- Very low power consumption: typ. 300 nA
- Standard operating temperature range T_A : -40 to +85°C
- Extended operating temperature range T_B : -40 to +125°C
- Synchronized CLKOUT enable/disable
- Low aging rate
- Miniature ceramic SMD package, RoHS-compliant and 100% lead-free: 3.2 x 1.5 x 1.0 mm

1.1. GENERAL DESCRIPTION

The OV-7604-C7 Medical combines an advanced very low power CMOS oscillator circuitry together with a 32.768 kHz “tuning-fork” crystal in a miniaturized ceramic package. No external components are required. The very low power consumption over a wide supply voltage and temperature range is the key feature of this product.

The frequency output on CLKOUT pin can be enabled/disabled synchronous by the CLKOE pin. The CLKOUT frequency is enabled when CLKOE pin is connected to V_{DD} . When the CLKOE pin is tied to GND the frequency is disabled and the CLKOUT pin is tied to Low State.

The OV-7604-C7 Medical Low Frequency Oscillator is manufactured specifically for use in implantable medical devices. The OV-7604-C7 Medical is also available in extended temperature range version (-40°C to +125°C).

1.2. APPLICATIONS

The OV-7604-C7 Medical oscillator module combines Medical Implantable Key Features with outstanding performance in a very small ceramic package:

- Smallest oscillator module (embedded XTAL) in a very small 3.2 x 1.5 x 1.0 mm lead-free ceramic package
- Safe for Helium environment: Ceramic lid with gold-tin preform-seal for best long-term hermeticity and stability

These unique features make this product perfectly suitable for many medical applications:

- Pacemakers / Defibrillators / Neurostimulators / Cardiac Monitoring Devices / Implantable Drug Delivery Pumps / Infusion Pumps / Cochlear Implants / Smart Orthopedic Implants / Glucose Meter / Health Monitoring Systems

1.3. ORDERING INFORMATION

Example: OV-7604-C7* T1 -20/+20ppm TA QM

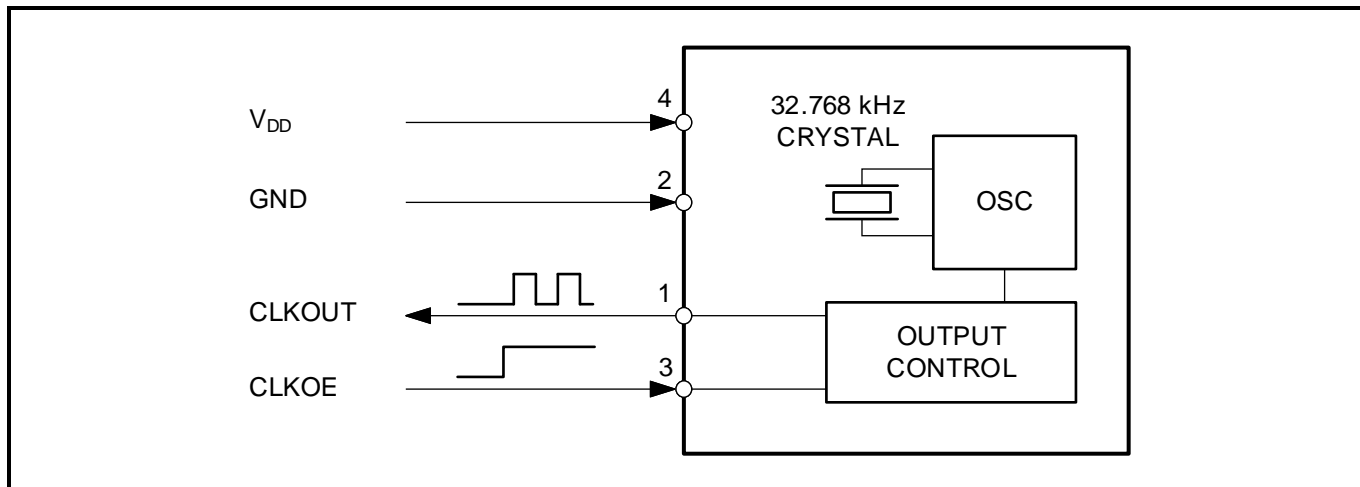
Code	Pads
T1	Au flashed pads
T5	ENEPIG plated pads

Code	Operating temperature range
TA	-40 to +85°C
TB	-40 to +125°C

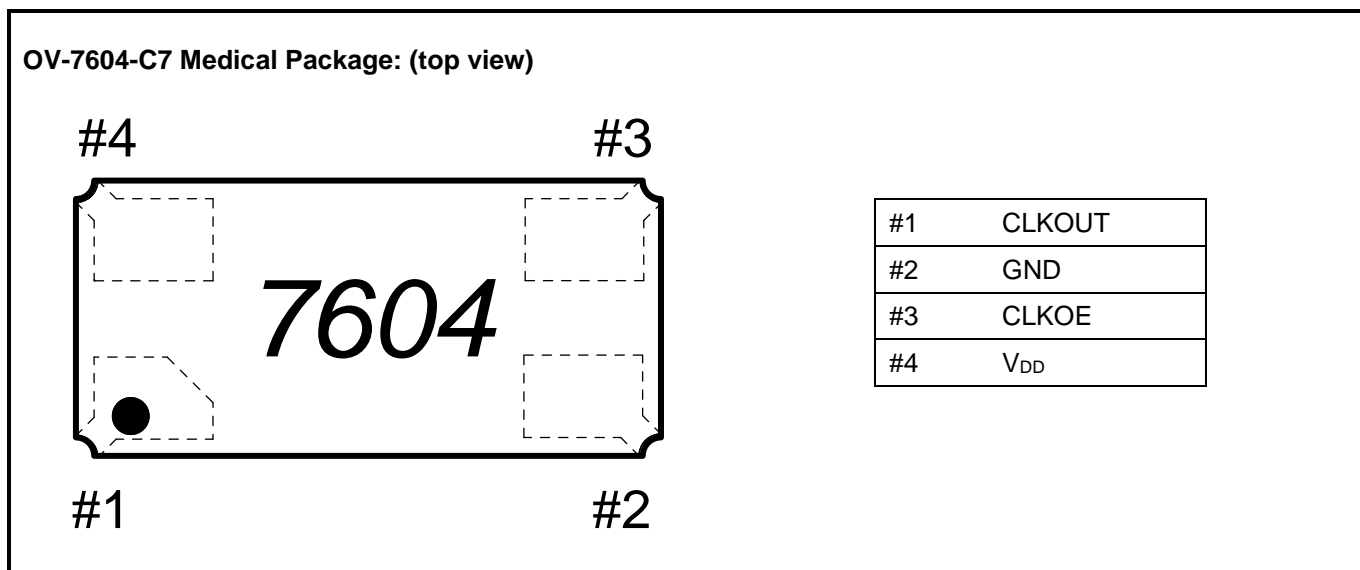
Code	Qualification
QM	Medical Grade

* The term Medical does not appear in the ordering information. QM implies medical.

2. BLOCK DIAGRAM



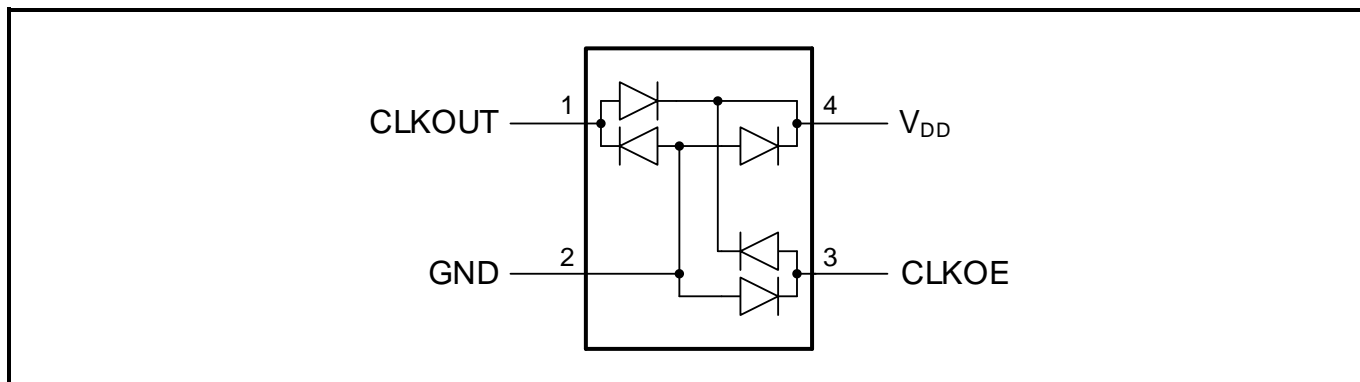
2.1. PINOUT



2.2. PIN DESCRIPTION

Symbol	Pin #	Description
CLKOUT	1	Clock Output; push-pull; controlled by CLKOE. If CLKOE is HIGH (V _{DD}), the CLKOUT pin drives the square wave of 32.768 kHz. When CLKOE is tied to Ground, the CLKOUT pin is LOW.
GND	2	Ground.
CLKOE	3	Input to enable the CLKOUT pin. If CLKOE is HIGH, the CLKOUT pin is in output mode. When CLKOE is tied to Ground, the CLKOUT pin is LOW.
V _{DD}	4	Power Supply Voltage.

2.3. DEVICE PROTECTION DIAGRAM



3. ELECTRICAL SPECIFICATIONS

3.1. ABSOLUTE MAXIMUM RATINGS

Absolute Maximum Ratings according to IEC 60134:

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V _{DD}	Power supply voltage		-0.3	6.0	V
V _I	Input voltage		-0.3	6.0	V
V _O	Output voltage		-0.3	6.0	V
P _{TOT}	Total power dissipation			300	mW
V _{ESD}	Electrostatic discharge Voltage	HBM (1)		±2000	V
I _{LU}	Latch-up current	(2)		±100	mA
T _{OPRA}	Standard operating temperature T _A		-40	85	°C
T _{OPRB}	Extended operating temperature T _B		-40	125	°C
T _{STO}	Storage temperature	Stored as bare product	-55	125	°C
T _{PEAK}	Maximum reflow condition	JEDEC J-STD-020C		265	°C

(1) HBM: Human Body Model, according to JESD22-A114.

(2) Latch-up testing, according to JESD78., Class I (room temperature), level A (100 mA).

3.2. OPERATING PARAMETERS

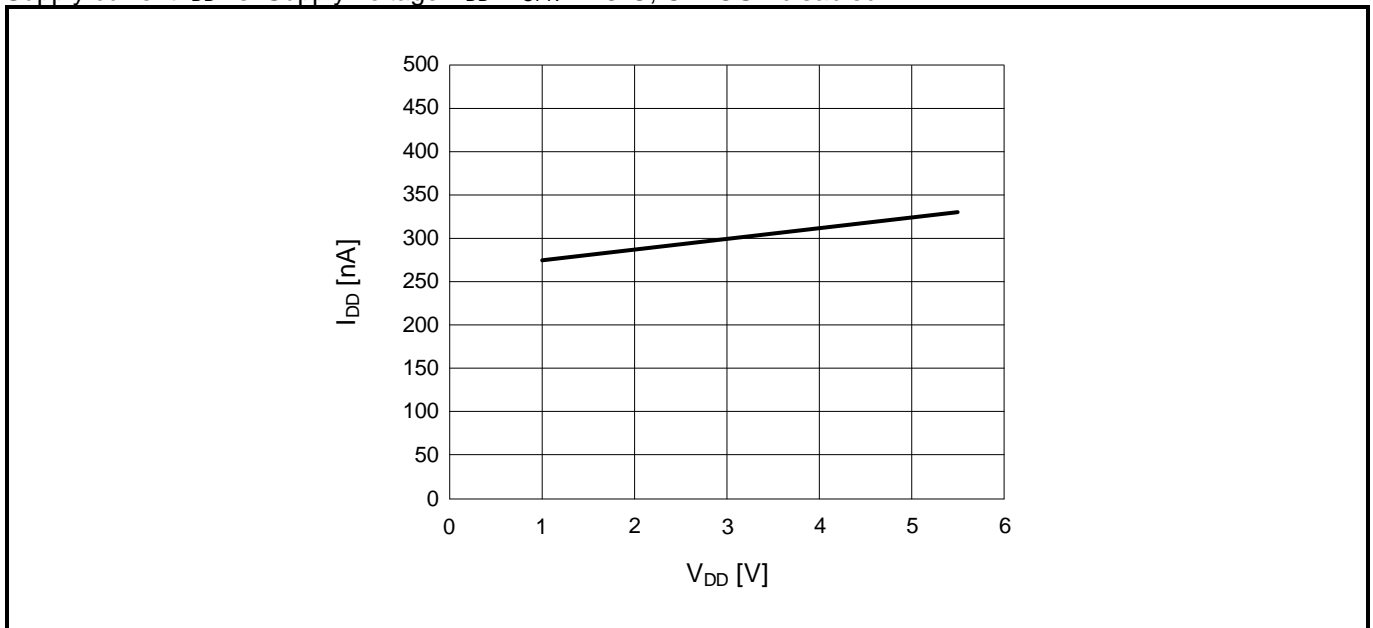
For this Table, V_{DD} = 3.0 V; GND = 0 V; T_{OPR} = 25°C; unless otherwise indicated.

Operating Parameters:

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Supply						
V _{DD}	Power supply voltage	T _{OPR} = -30 to 125°C	1.2		5.5	V
		T _{OPR} = -40 to -30°C	1.3		5.5	
V _{DDSR}	V _{DD} slew rate				±0.5	V/ms
I _{DD}	V _{DD} Supply Current. CLKOUT disabled. (1)	V _{DD} = 3.0 V, T _{OPR} = 25°C		300	500	nA
		V _{DD} = 5.0 V, T _{OPR} = 25°C		320	550	
		V _{DD} = 3.0 V, T _A = -40 to 85°C			1000	
		V _{DD} = 5.0 V, T _A = -40 to 85°C			1100	
		V _{DD} = 3.0 V, T _B = -40 to 125°C			1500	
		V _{DD} = 5.0 V, T _B = -40 to 125°C			1650	
Input CLKOE						
V _I	Input voltage		GND -0.3		V _{DD} +0.3	V
V _{IL}	LOW level input voltage		GND		0.2 V _{DD}	V
V _{IH}	HIGH level input voltage		0.8 V _{DD}		V _{DD}	V
Output CLKOUT						
V _{OH}	HIGH level output voltage	I _{OH} = -1.0 mA	V _{DD} - 0.4			V
V _{OL}	LOW level output voltage	I _{OL} = 1.0 mA			GND +0.4	V
C _L	Output load capacitance	CMOS			15	pF
t _r	Output rise time	C _L = 10 pF, 10% to 90% V _{DD}		70	100	ns
t _f	Output fall time	C _L = 10 pF, 10% to 90% V _{DD}		70	100	ns
t _{CKH}	Synchronized CLKOUT enable time (see following diagram)		15.3		45.8	µs
t _{CKL}	Synchronized CLKOUT disable time (see following diagram)		0		15.3	µs
(1) When CLKOUT is enabled (CLKOE is HIGH) the additional V _{DD} supply current ΔI _{DD} can be calculated as follows: ΔI _{DD} = C _L × V _{DD} × f _{OUT} e.g. ΔI _{DD} = 10 pF × 3.0 V × 32'768 Hz = 980 nA						

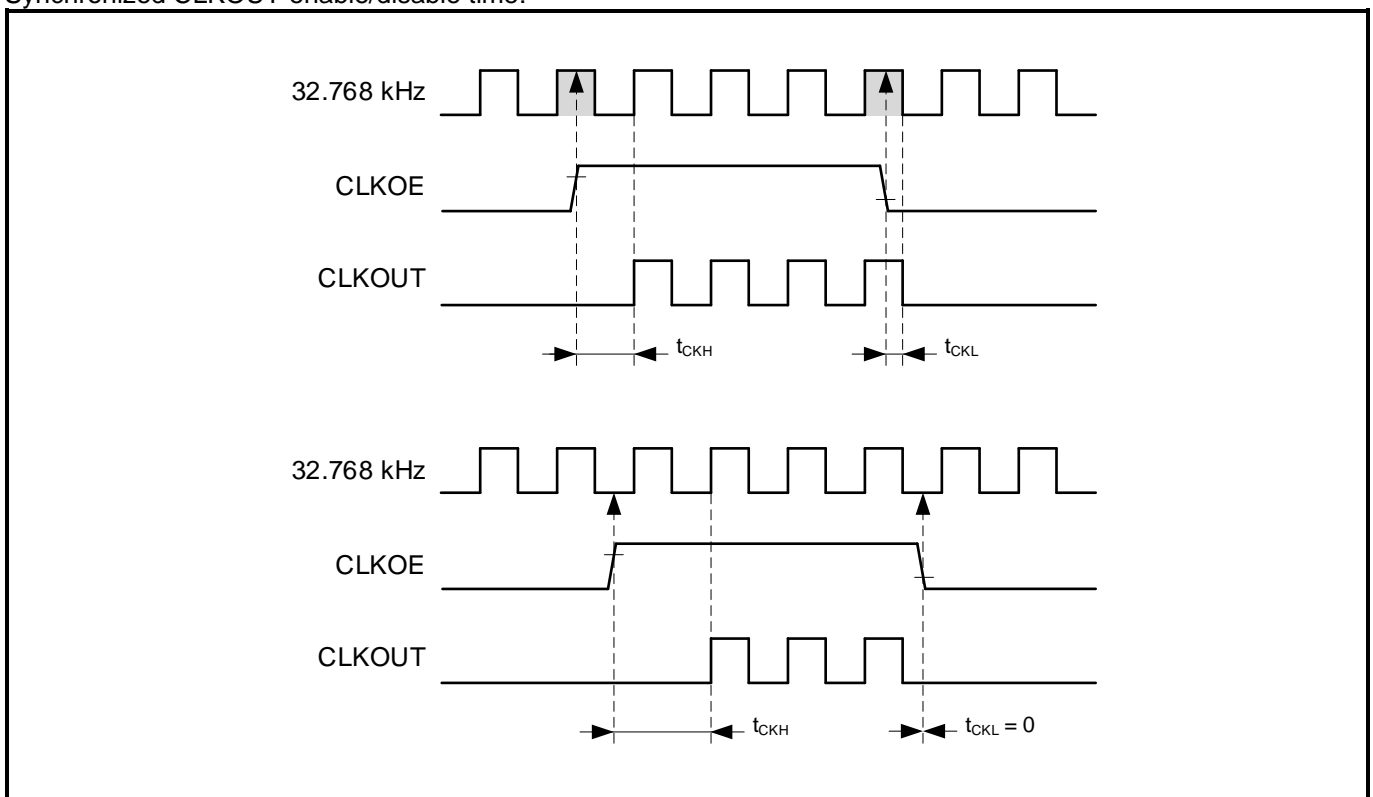
3.3. TYPICAL CHARACTERISTICS

Supply current I_{DD} vs. Supply voltage V_{DD} : $T_{OPR} = 25^{\circ}\text{C}$, CLKOUT disabled



3.4. TIMING WAVEFORMS

Synchronized CLKOUT enable/disable time:



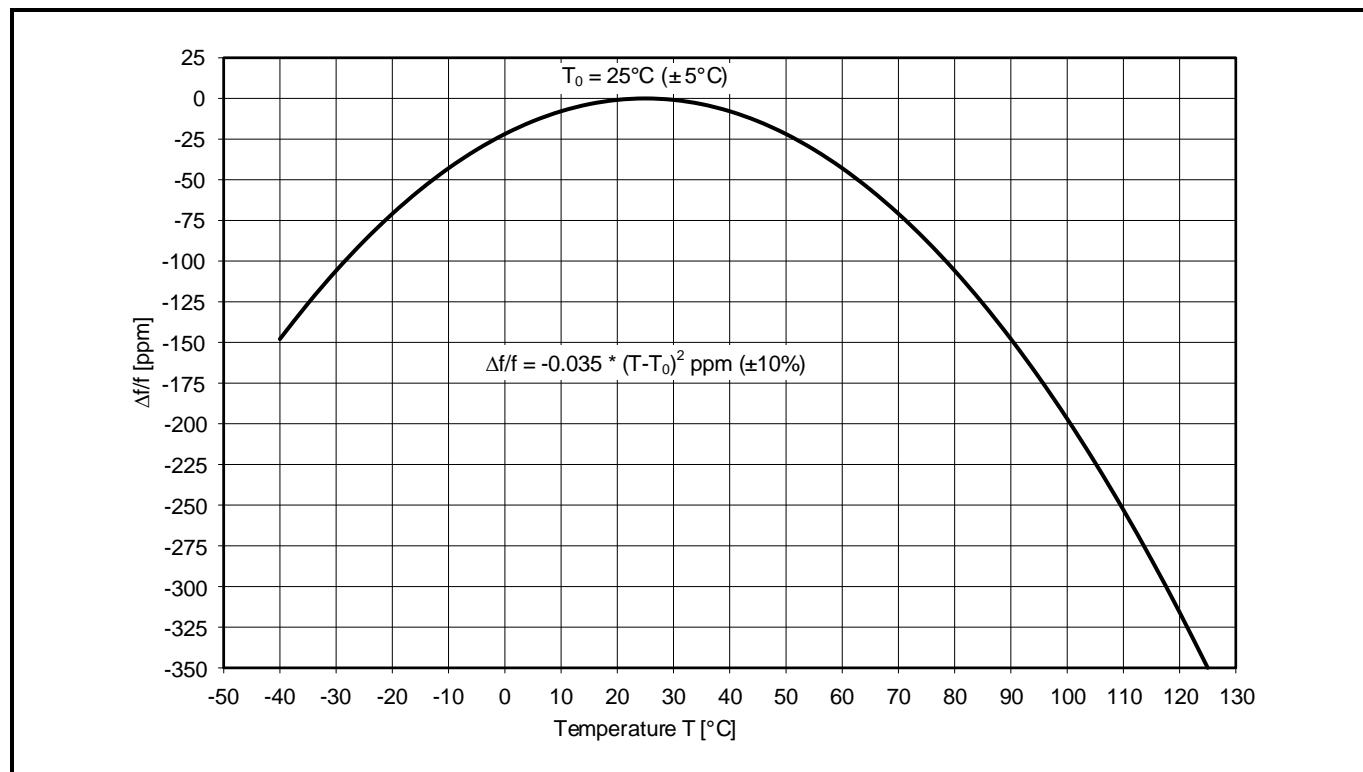
3.5. OSCILLATOR PARAMETERS

For this Table, $V_{DD} = 3.0\text{ V}$; $GND = 0\text{ V}$; $T_{OPR} = 25^\circ\text{C}$; unless otherwise indicated.

Oscillator Parameters:

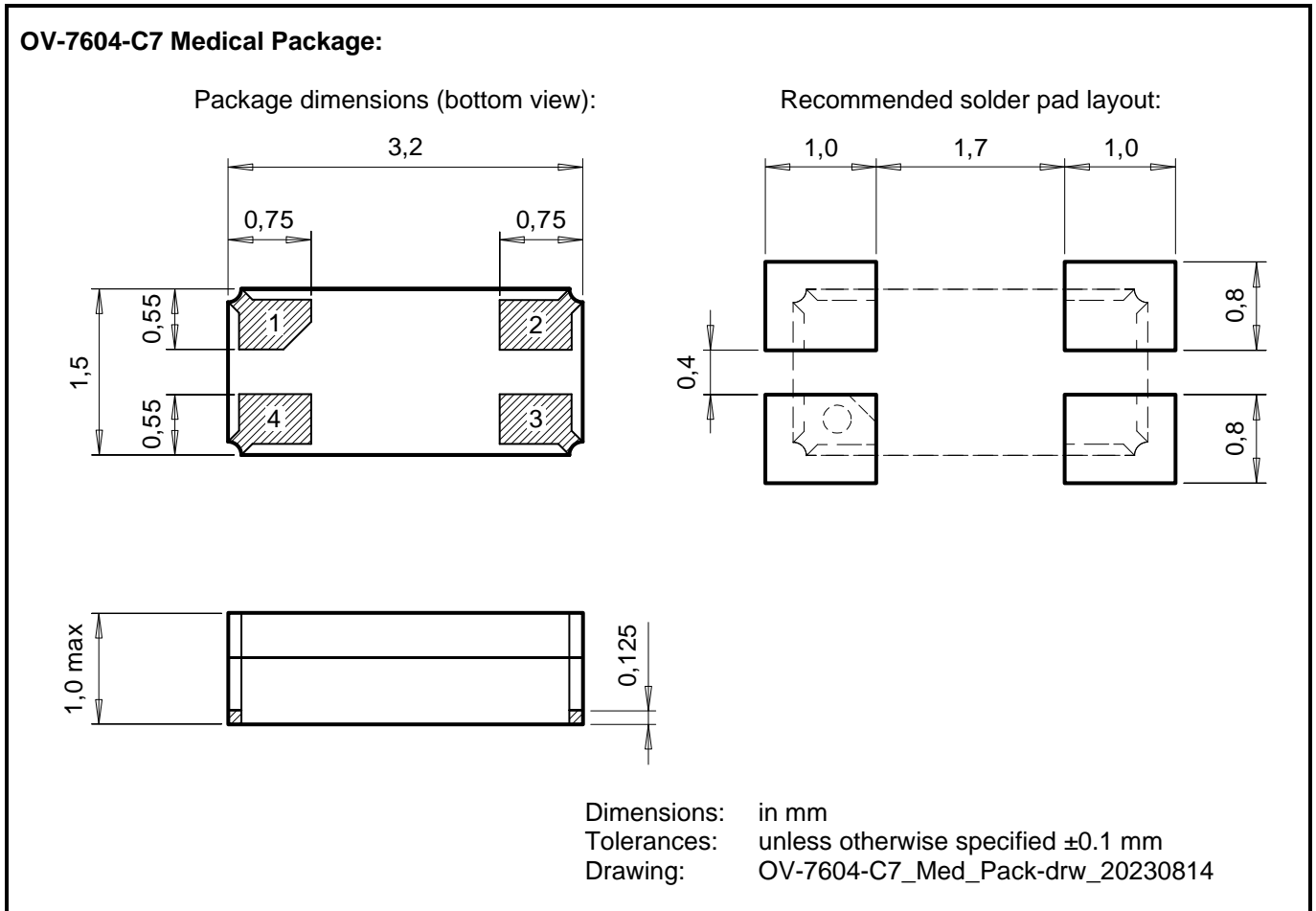
SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
Xtal General						
f	Crystal Frequency			32.768		kHz
t _{START}	Oscillator start-up time			0.4	0.8	s
δ_{CLKOUT}	CLKOUT duty cycle	$T_{OPR} = -30\text{ to }125^\circ\text{C}$ $V_{DD} = 1.2\text{ to }5.5\text{ V}$	40		60	%
		$T_{OPR} = -40\text{ to }-30^\circ\text{C}$ $V_{DD} = 1.3\text{ to }5.5\text{ V}$				
Xtal Frequency Characteristics						
$\Delta f/f$	Frequency accuracy			± 10	± 20	ppm
$\Delta f/V$	Frequency vs. voltage characteristics	$1.5\text{ V} \leq V_{DD} \leq 5.5\text{ V}$			± 1.5	ppm/V
$\Delta f/f_{TOPR}$	Frequency vs. temperature characteristics	$T_{OPR} = -40^\circ\text{C to }+125^\circ\text{C}$ $V_{DD} = 3.0\text{ V}$	$-0.035\text{ ppm}/^\circ\text{C}^2 (T_{OPR}-T_0)^2 \pm 10\%$			ppm
T ₀	Turnover temperature		20		30	°C
$\Delta f/f$	Aging first year max.				± 2	ppm

3.5.1.XTAL FREQUENCY VS. TEMPERATURE CHARACTERISTICS



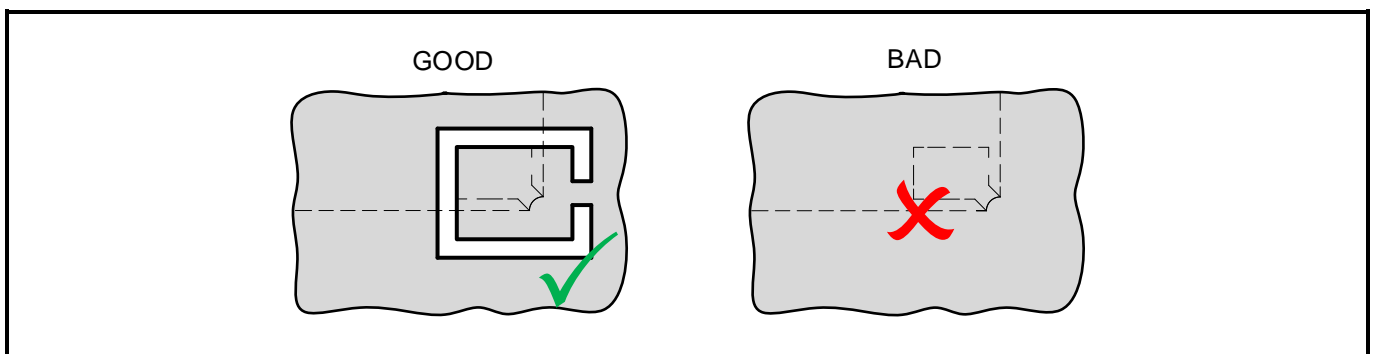
4. PACKAGE

4.1. DIMENSIONS AND SOLDER PAD LAYOUT



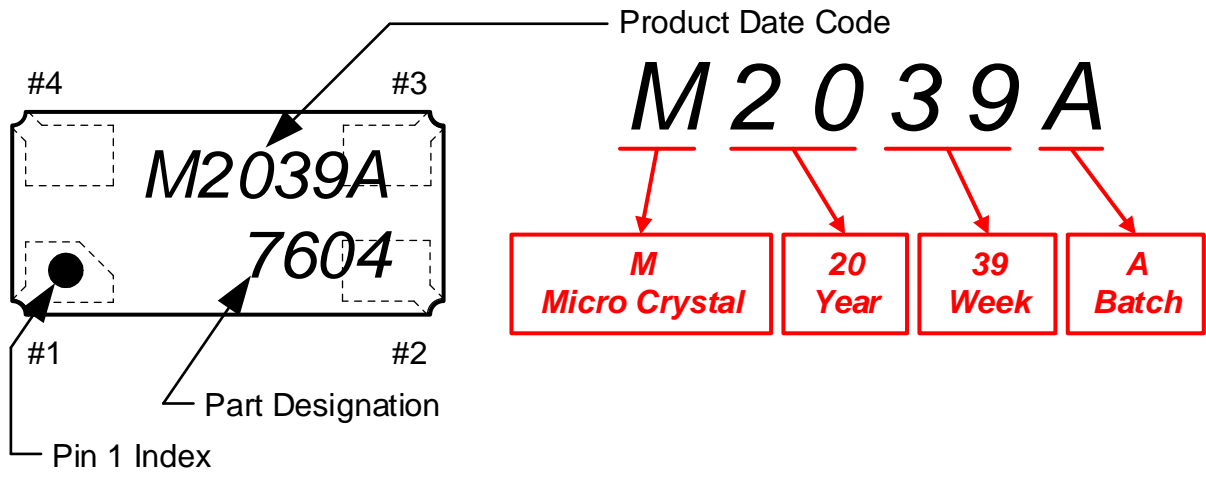
4.1.1. RECOMMENDED THERMAL RELIEF

When connecting a pad to a copper plane, thermal relief is recommended.



4.2. MARKING AND PIN #1 INDEX

Laser marking OV-7604-C7 Medical Package: (top view)

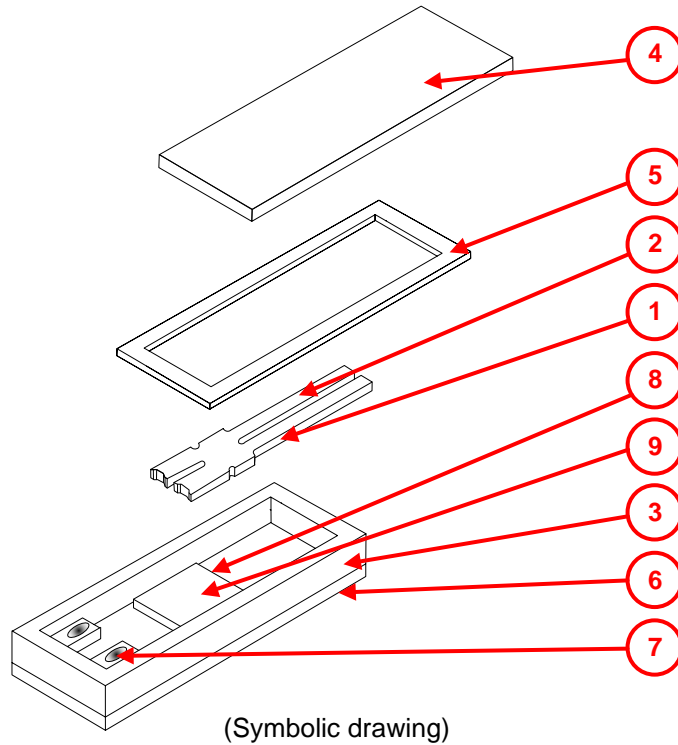


5. MATERIAL COMPOSITION DECLARATION & ENVIRONMENTAL INFORMATION

5.1. HOMOGENOUS MATERIAL COMPOSITION DECLARATION

Homogenous material information according to IPC-1752 standard

Material Composition OV-7604-C7 Medical:



No.	Item Component Name	Sub Item Material Name	Material Weight		Substance Element	CAS Number	Comment
			(mg)	(%)			
1	Resonator	Quartz Crystal	0.27	100%	SiO ₂	14808-60-7	
2	Electrodes	Cr+Au	0.005	6%	Cr	Cr: 7440-47-3	
				94%	Au	Au: 7440-57-5	
3	Housing	Ceramic	6.30	100%	Al ₂ O ₃	1344-28-1	
4	Lid	Ceramic	4.65	98.5%	Al ₂ O ₃	1344-28-1	Ceramic Lid
		Ni-plating		1.0%	Ni	Ni: 7440-02-0	Nickel plating
		Au-plating		0.5%	Au	Au: 7440-57-5	Gold plating
5	Seal	Solder Preform	0.38	80%	Au80 / Sn20	Au: 7440-57-5	
				20%		Sn: 7440-31-5	
6	Terminations	Internal and external terminals	0.33	80%	Mo	Mo: 7439-98-7	Molybdenum
				15%	Ni	Ni: 7440-02-0	Nickel plating
				5%	Au 0.5 micron	Au: 7440-57-5	Gold plating
7	Conductive adhesive	Silver filled Silicone glue	0.09	88%	Ag	Ag: 7440-22-4	
				12%	Siloxanes and silicones	68083-19-2	di-Me, vinyl group-terminated
				0%	Distillates, petroleum hydrotreated	64742-47-8	Does not appear in finished product
8	CMOS IC	Silicon	0.34	94%	Si	Si: 7440-21-3	
		Die pad plating		6%	Au	Au: 7440-57-5	
9	Die attach	Gold bumps	0.025	100%	Au	Au: 7440-57-5	
		Unit weight	12.4				

5.2. MATERIAL ANALYSIS & TEST RESULTS

Homogenous material information according to IPC-1752 standard

No.	Item Component Name	Sub Item Material Name	RoHS						Halogens				Phthalates				
			Pb	Cd	Hg	Cr(VI)	PBB	PBDE	F	Cl	Br	-	BBP	DBP	DEHP	DIBP	
1	Resonator	Quartz Crystal	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
2	Electrodes	Cr+Au	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
3	Housing	Ceramic	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
4	Lid	Ceramic Lid & Plating	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
5	Seal	Solder Preform	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
6	Terminations	Int. & ext. terminals	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
7	Conductive adhesive	Silver filled Silicone glue	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
8	CMOS IC	Silicon & Die pad plating	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
9	Die attach	Gold bumps	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd	nd
	MDL [ppm]	Method Detection Limit	2			8	5	50				50					

nd (not detected) = below "Method Detection Limit" (MDL)

Test methods:

RoHS

- Pb, Cd
- Hg
- Cr(VI)
- PBB / PBDE

Test method with reference to:

- IEC 62321-5:2013
- IEC 62321-4:2013 + AMD1:2017
- IEC 62321-7-2:2017
- IEC 62321-6:2015

- MDL: 2 ppm
- MDL: 2 ppm
- MDL: 8 ppm
- MDL: 5 ppm

Halogens

Test method with reference to BS EN 14582:2016

MDL: 50 ppm

Phthalates

Test method with reference to IEC 62321-8:2017

MDL: 50 ppm

5.3. RECYCLING MATERIAL INFORMATION

Recycling material information according to IPC-1752 standard.

Element weight is accumulated and referenced to the unit weight of 12.4 mg.

Item Material Name	No.	Item Component Name	Material Weight		Substance Element	CAS Number	Comment
			(mg)	(%)			
Quartz Crystal	1	Resonator	0.27	2.18	SiO ₂	14808-60-7	
Chromium	2	Electrodes	0.0003	0.002	Cr	Cr: 7440-47-3	
Ceramic	3	Housing	10.88	87.81	Al ₂ O ₃	1344-28-1	
	4	Lid					
Gold	2	Electrodes	0.39	3.18	Au	Au: 7440-57-5	
	4	Lid					
	5	Seal					
	6	Terminations					
	8	CMOS IC					
9	Die attach						
Tin	5	Seal	0.076	0.61	Sn	Sn: 7440-31-5	
Nickel	4	Lid	0.096	0.77	Ni	Ni: 7440-02-0	
	6	Terminations					
Molybdenum	6	Terminations	0.26	2.13	Mo	Mo: 7439-98-7	
Silver	7a	Conductive adhesive	0.079	0.64	Ag	Ag: 7440-22-4	
Siloxanes and silicones	7b	Conductive adhesive	0.011	0.09	Siloxanes and silicones	68083-19-2	di-Me, vinyl group-terminated
Distillates	7c	Conductive adhesive	0	0	Distillates	64742-47-8	hydrotreated petroleum, does not appear in finished products
Silicon	8	CMOS IC	0.32	2.58	Si	Si: 7440-21-3	
Unit weight (total)			12.4	100			

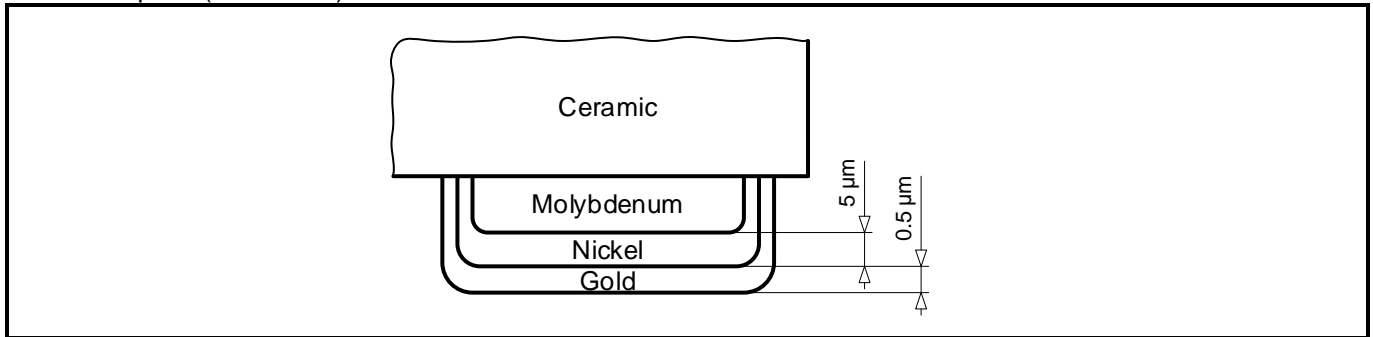
5.4. ENVIRONMENTAL PROPERTIES & ABSOLUTE MAXIMUM RATINGS

Package	Description
SON-4 ceramic package	Small Outline Non-leaded (SON), hermetically sealed ceramic package with ceramic lid. Safe for Helium environment.

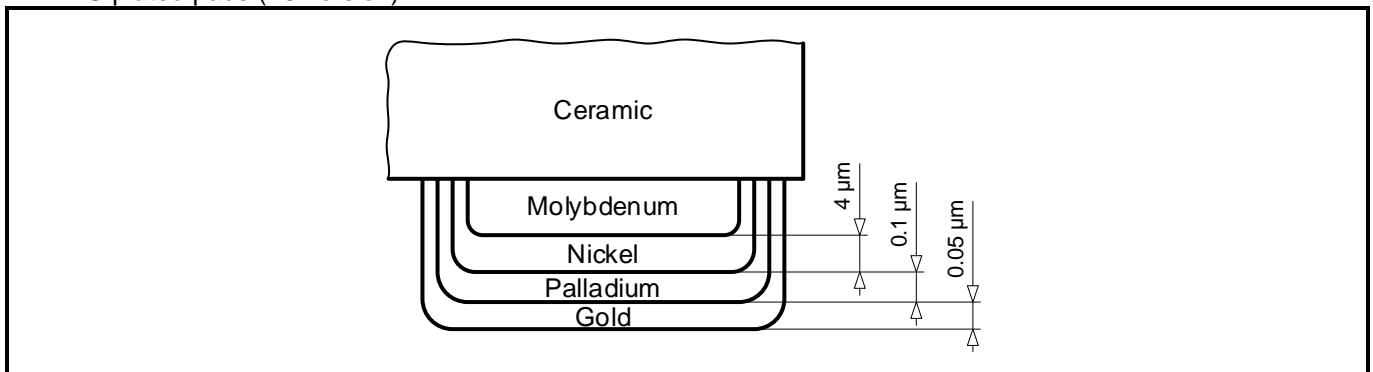
Parameter	Directive	Conditions	Value
Product weight (total)			12.4 mg
Storage temperature		Store as bare product	-55 to +125°C
Moisture sensitivity level (MSL)	IPC/JEDEC J-STD-020D		MSL1
FIT / MTBF			available on request

Terminal finishes:

Au flashed pads (T1 version):

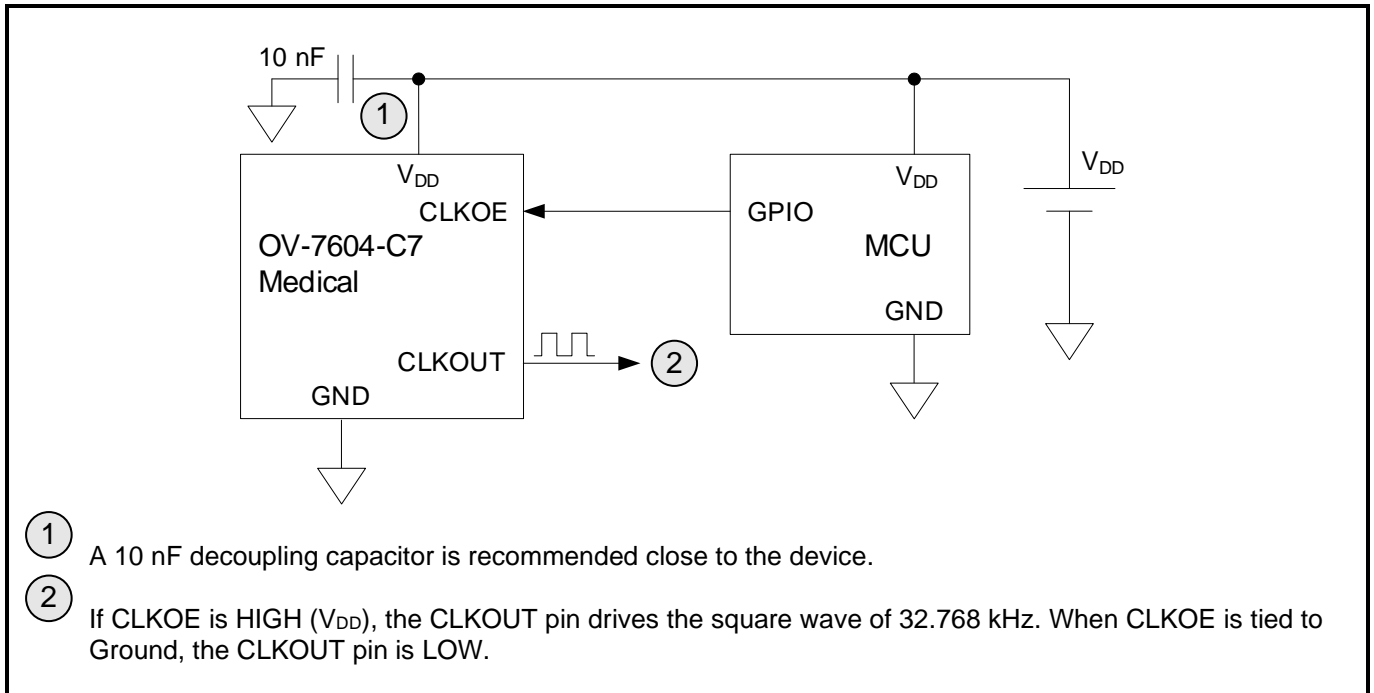


ENEPIG plated pads (T5 version):

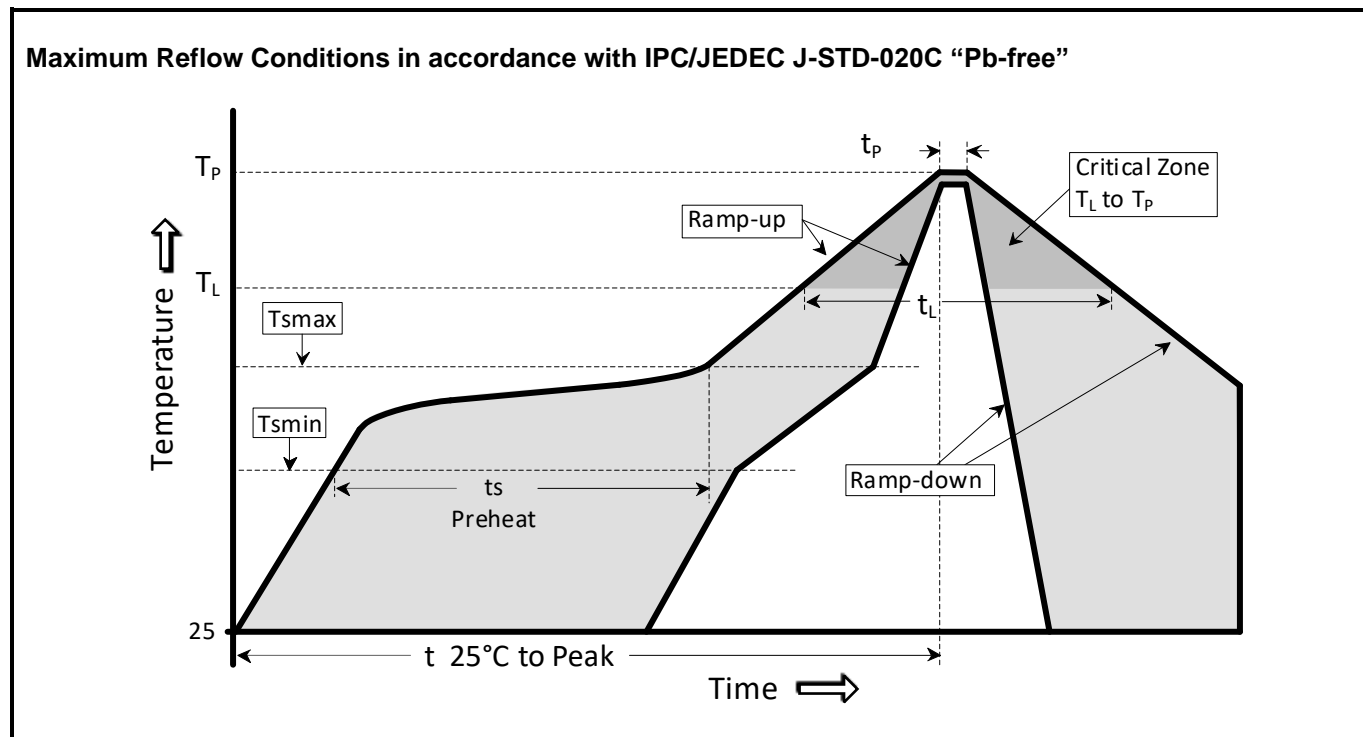


6. APPLICATION INFORMATION

6.1. OPERATING OV-7604-C7 MEDICAL



6.2. SOLDERING INFORMATION



Temperature Profile	Symbol	Condition	Unit
Average ramp-up rate	(T_{Smax} to T_P)	3°C / second max	°C / s
Ramp down Rate	T_{cool}	6°C / second max	°C / s
Time 25°C to Peak Temperature	$T_{to-peak}$	8 minutes max	min
Preheat			
Temperature min	T_{Smin}	150	°C
Temperature max	T_{Smax}	200	°C
Time T_{Smin} to T_{Smax}	t_s	60 – 180	sec
Soldering above liquidus			
Temperature liquidus	T_L	217	°C
Time above liquidus	t_L	60 – 150	sec
Peak temperature			
Peak Temperature	T_p	260	°C
Time within 5°C of peak temperature	t_p	20 – 40	sec

6.3. HANDLING PRECAUTIONS FOR MODULES WITH EMBEDDED CRYSTALS

The built-in tuning-fork crystal consists of pure Silicon Dioxide in crystalline form. The cavity inside the package is evacuated and hermetically sealed in order for the crystal blank to function undisturbed from air molecules, humidity and other influences.

Shock and vibration:

Keep the crystal / module from being exposed to **excessive mechanical shock and vibration**. Micro Crystal guarantees that the crystal / module will bear a mechanical shock of 5000 g / 0.3 ms.

The following special situations may generate either shock or vibration:

Multiple PCB panels - Usually at the end of the pick & place process the single PCBs are cut out with a router. These machines sometimes generate vibrations on the PCB that have a fundamental or harmonic frequency close to 32.768 kHz. This might cause breakage of crystal blanks due to resonance. Router speed should be adjusted to avoid resonant vibration.

Ultrasonic cleaning - Avoid cleaning processes using ultrasonic energy. These processes can damage the crystals due to the mechanical resonance frequencies of the crystal blank.

Overheating, rework high temperature exposure:

Avoid overheating the package. The package is sealed with a seal ring consisting of 80% Gold and 20% Tin. The eutectic melting temperature of this alloy is at 280°C. Heating the seal ring up to >280°C will cause melting of the metal seal which then, due to the vacuum, is sucked into the cavity forming an air duct. This happens when using hot-air-gun set at temperatures >280°C.

Use the following methods for rework:

- Use a hot-air-gun set at 270°C.
- Use 2 temperature controlled soldering irons, set at 270°C, with special-tips to contact all solder-joints from both sides of the package at the same time, remove part with tweezers when pad solder is liquid.

8. COMPLIANCE INFORMATION

Micro Crystal confirms that the product Low Power Clock Oscillator OV-7604-C7 Medical is compliant with “EU RoHS Directive” and “EU REACH Directives”.

Please find the actual Certificate of Conformance for Environmental Regulations on our website:

[CoC Environment OV_OM-Series.pdf](#)

9. DOCUMENT REVISION HISTORY

Date	Revision #	Revision Details
February 2021	1.0	First release
August 2023	1.1	Changed term "SMT" to "SMD", 1. Removed T2 version from the ordering information, 1.3. Improved Block Diagram, 2. Added " $\Delta f/f =$ " at formula and "T" at X axis, 3.5.1. Updated package drawing 4.1. Added "Dimensions: in mm", 4.1. Adapted limit values and methods in accordance with the latest standards, 5.2. Changed package designation from DFN-4 to SON-4, 5.4. Corrected text to "hot-air-gun set at temperatures >280°C.", 6.3. Replaced Tape drawing with new version, 7.

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